

Ambient 4-probe Surface Measurement System

UP2000-4P

This system enables various kinds of "micron-order" to "nano-order" surface electricity measurements and manipulation in the atmosphere.

Main applications

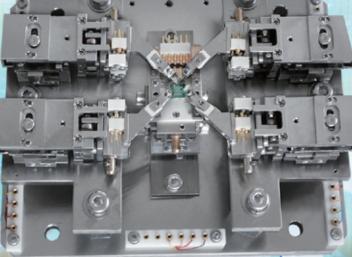
- Micro to nano-manipulation of samples
- Measurements of various kinds of electric properties of sample surfaces by multi-probing





Notebook PC

- You can control the positions of each of the four probes individually along the three axes, X, Y, and Z, using a personal computer and a remote control, while observing the sample surface under an optical microscope.
- You don't need to make troublesome sample position adjustments, as the sample stage can also be moved independently in the X and Y directions.
- This system can also be used to heat samples.
- You can manipulate samples easily and intuitively while observing the sample surface shown on the screen of your personal computer.



4-probe stage and optical microscope

We can also manufacture high-vacuum systems for probing and surface measurements in a vacuum.

Please feel free to ask us any questions you may have.



(custom-order)
nstrumental components subject to change without prior notice for improvement inperformance.

Ambient 4-probe Surface Measurement System

UP2000-4P

Configuration

4-probe stage main body (with an optical microscope)	1
4-probe controller (with a remote control)	1
Notebook PC for control and observation (with a control program)	1
PT-Ir probes	1 set



Specifications

Optical microscope and CCD camera

Minimum resolution	2 μ m to 13 μ m (when the standard lens is used)
	Equipped with a zoom function as standard
	CCD camera 2 million pixels
	Maximum display size 1600 x 1200
	Equipped with an illumination source and fiber as standard

4-probe stage

140 mm long x 140 mm wide
200 mm dia.
XY 5 mm, Z 3mm
1 μm
Pulse control and linear control modes

Sample stage

Maximum travel range	X-axis 10 mm	
	Y-axis 5 mm	
	Driving method	Pulse control
* The heating and cooling stages are available as entions		

The heating and cooling stages are available as options.

Sample holder

Maximum sample size	10 mm x 10 mm			
2 contacts for applying the current for heating				
* 5 contact terminals are available for users.				

Probes

Probe tip diameter 0.5 mm to 0.3 mm		
Other probes are available as options		
We offer Pt-Ir and tungsten probes.		
Each probe tip is provided as a measurement terminal.		

Control unit				
Dedicated 4-probe controller				
Input voltage	100 to 115 VAC (50 Hz, 60 Hz)			
	200 VA (MAX)			
Input	Dedicated control terminal			
Output	Dedicated 4-probe terminals (4 outputs)			
Display function	LED to indicate the pulse-controlled movements			
	in the X, Y and Z-directions			
Dedicated stag	Dedicated stage controller			
Input voltage	100 to 115 VAC (50 Hz, 60 Hz)			
	100 VA (MAX)			
Output terminal	Stage control terminal			
	X and Y axes (manually switched)			
Input terminal	Dedicated external remote control terminal			
	Equipped with a remote control as standard			
Personal computer for control				
Notebook PC (compatible with Windows XP and Windows VISTA)				
Pre-installed with the dedicated control software				
Equipped with a dedicated remote control as standard				

* Electric property measurement circuits and other necessary items should be prepared by the user.

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